

## Features

- Temperature-compensated: 15 ppm/ $^{\circ}\text{C}$
- Trimmed bandgap reference
- Internal amplifier with 100 mA capability
- Multiple temperature ranges
- Low frequency dynamic output impedance: < 450 m $\Omega$
- Low output noise

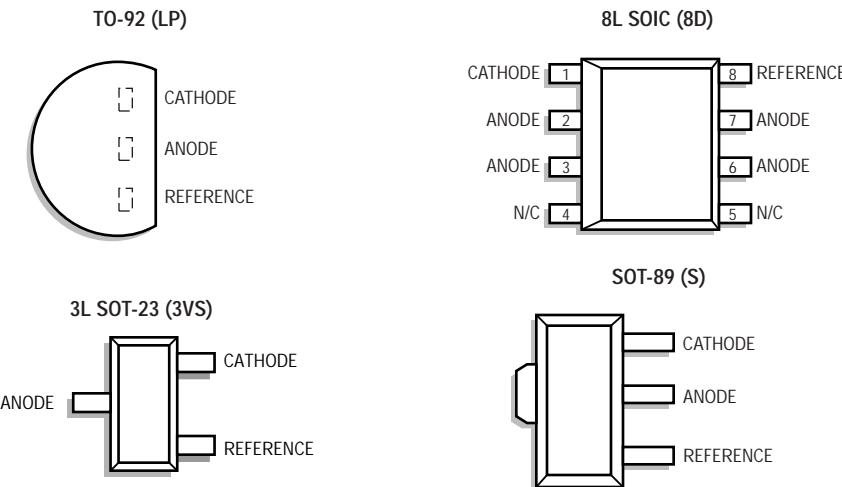
## Description

The AS2431 is a three-terminal adjustable shunt regulator providing a highly accurate bandgap reference. The adjustable shunt regulator is ideal for a wide variety of linear applications that can be implemented using external components to obtain adjustable currents and voltages.

In the standard shunt configuration, the combination of low temperature coefficient (TC), sharp turn-on characteristics, low output impedance and programmable output voltage make this precision reference an excellent error amplifier.

The AS2431 is a direct replacement for the AS431 in low voltage, low current applications. It is also available in the very small footprint SOT-23.

## Pin Configuration – Top View



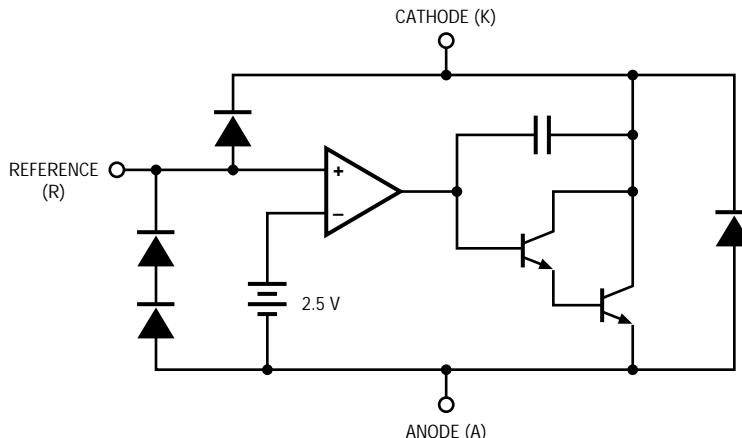
## Ordering Information

Circuit Type: _____	AS2431	A	C	8D	N
Precision Adjustable Shunt Regulator					
Bandgap Tolerance: _____					
A = $\pm 0.25\%$ C = $\pm 0.5\%$ D = $\pm 1.0\%$ E = $\pm 2.0\%$					
Temperature Range: _____					
A = $0^{\circ}\text{C}$ to $70^{\circ}\text{C}$ B = $0^{\circ}\text{C}$ to $105^{\circ}\text{C}$ C = $-40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$ F = $-55^{\circ}\text{C}$ to $+125^{\circ}\text{C}$					

Packaging Option:  
 A = Ammo Pack  
 B = Bulk  
 T = Tube  
 M = Tape and Reel ( $7^{\prime\prime}$  Reel Dia. SOT-23 Only)  
 N = Tape and Reel ( $13^{\prime\prime}$  Reel Dia)

Package Style:  
 8D = 8 Pin, Plastic SOIC  
 LP = TO-92  
 S = SOT-89  
 3VS = 3 Pin, SOT-23

## Functional Block Diagram



[www.DataSheet4U.com](http://www.DataSheet4U.com)

## Absolute Maximum Ratings

Parameter	Symbol	Rating	Units
Cathode-Anode Reverse Breakdown	$V_{KA}$	18	V
Anode-Cathode Forward Current	$I_{AK}$	1	A
Operating Cathode Current	$I_{KA}$	100	mA
Reference Input Current	$I_{REF}$	1	mA
Continuous Power Dissipation at 25°C	$P_D$		
TO-92		775	mW
8L SOIC		750	mW
SOT-89		1000	mW
3L SOT-23		200	mW
Junction Temperature	$T_J$	150	°C
Storage Temperature	$T_{STG}$	-65 to 150	°C
Lead Temp, Soldering 10 Seconds	$T_L$	300	°C

Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

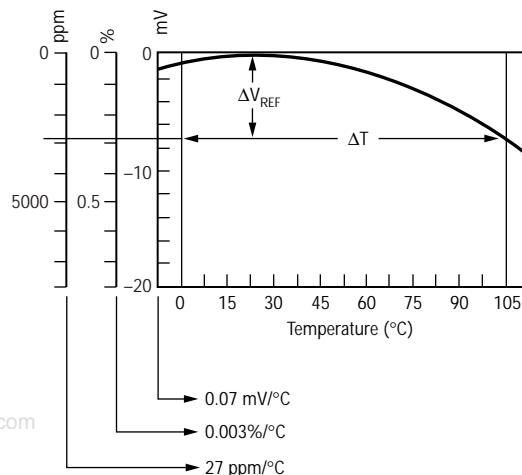
## Recommended Conditions

Parameter	Symbol	Rating	Unit
Cathode Voltage	$V_{KA}$	$V_{REF}$ to 18	V
Cathode Current	$I_K$	10	mA

## Typical Thermal Resistances

Package	$\theta_{JA}$	$\theta_{JC}$	Typical Derating
TO-92	160°C/W	80°C/W	6.3 mW/°C
SOIC	175°C/W	45°C/W	5.7 mW/°C
SOT-89	110°C/W	8°C/W	9.1 mW/°C
SOT-23/5L	575°C/W	150°C/W	1.7 mW/°C

## Average Temperature Coefficient



$$\bullet \text{ TC in mV/}^{\circ}\text{C} = \frac{\Delta V_{REF} (\text{mV})}{\Delta T_A}$$

$$\bullet \text{ TC in \%/\text{ } }^{\circ}\text{C} = \left( \frac{\Delta V_{REF}}{V_{REF} \text{ at } 25^{\circ}\text{C}} \right) \times 100$$

$$\bullet \text{ TC in ppm/}^{\circ}\text{C} = \left( \frac{\Delta V_{REF}}{V_{REF} \text{ at } 25^{\circ}\text{C}} \right) \times 10^6$$

## Test Circuits

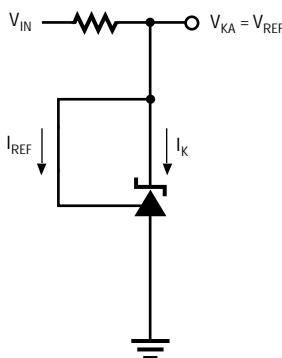


Figure 1a. Test Circuit 1

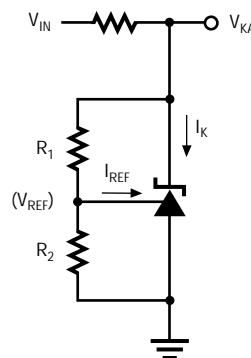


Figure 1b. Test Circuit 2

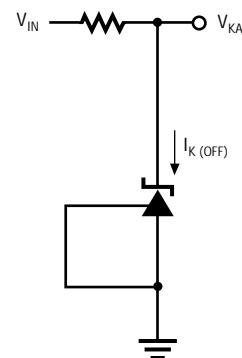


Figure 1c. Test Circuit 3

## Typical Performance Curves

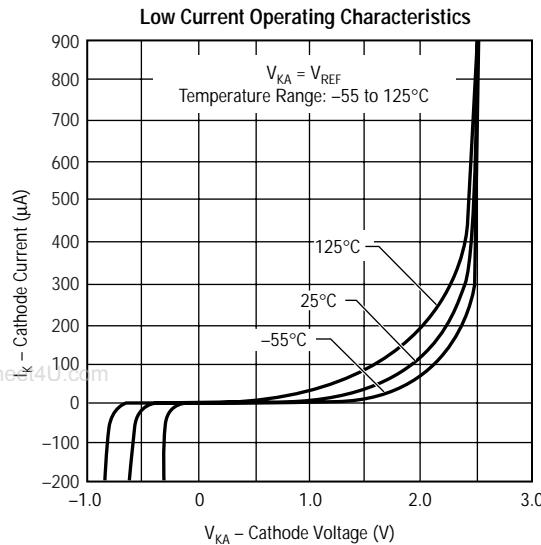


Figure 2

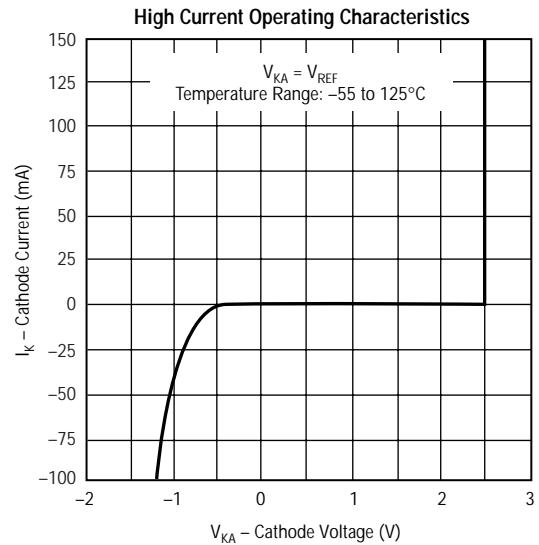


Figure 3

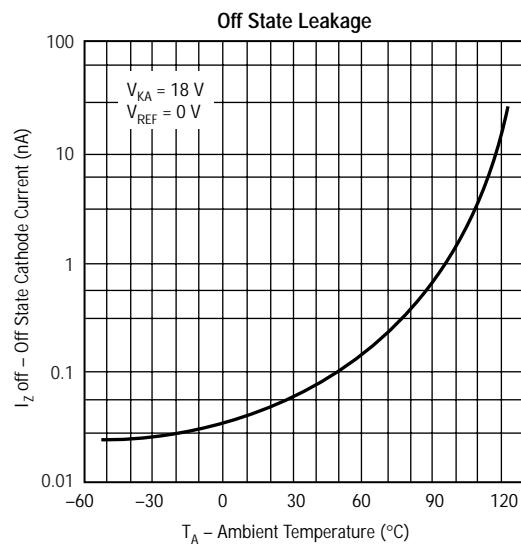


Figure 4

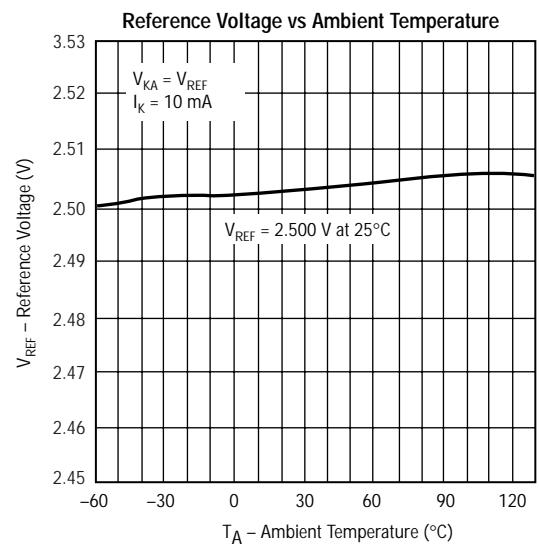


Figure 5

## Typical Performance Curves

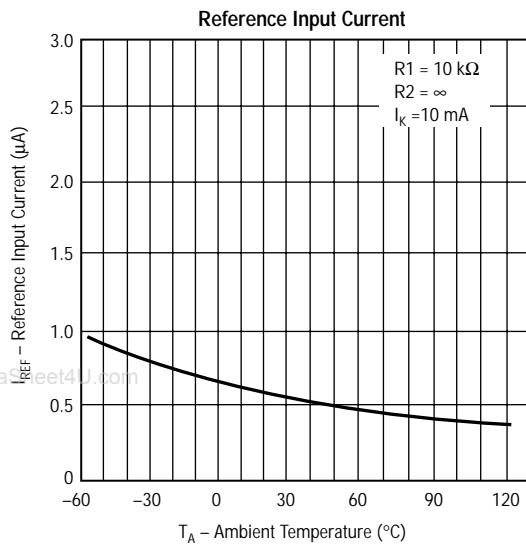


Figure 6

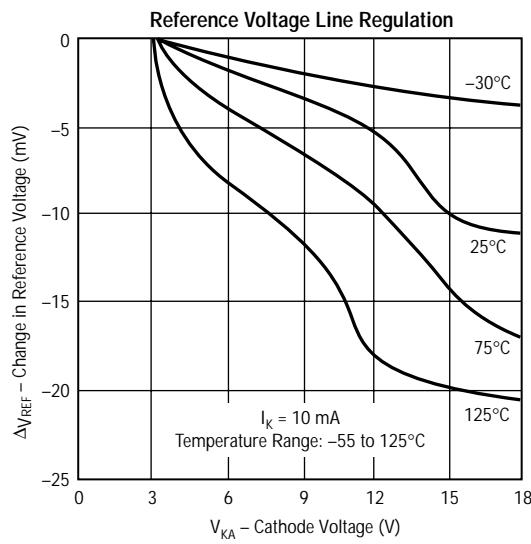


Figure 7

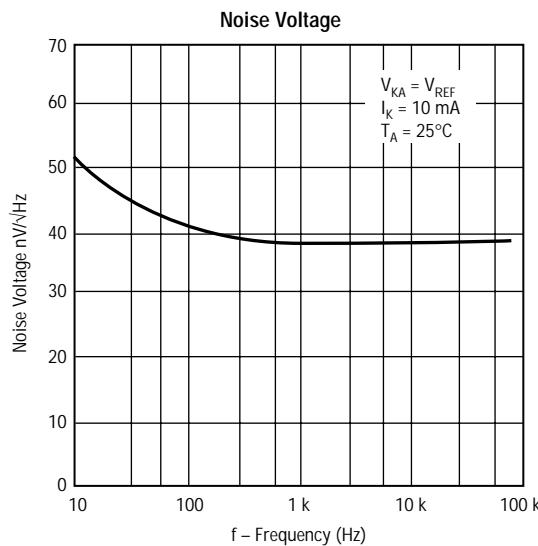


Figure 8

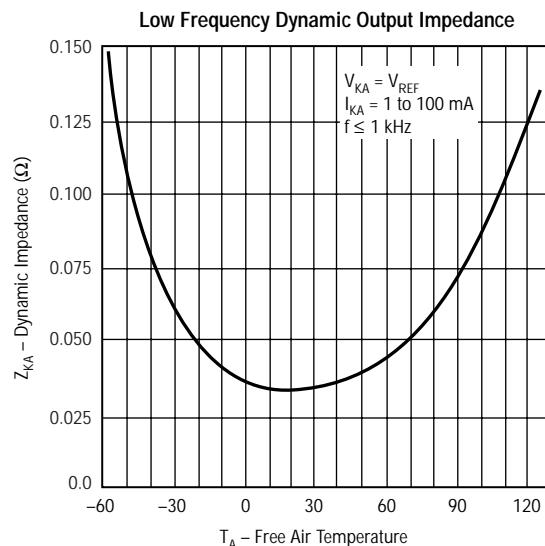


Figure 9

## Typical Performance Curves

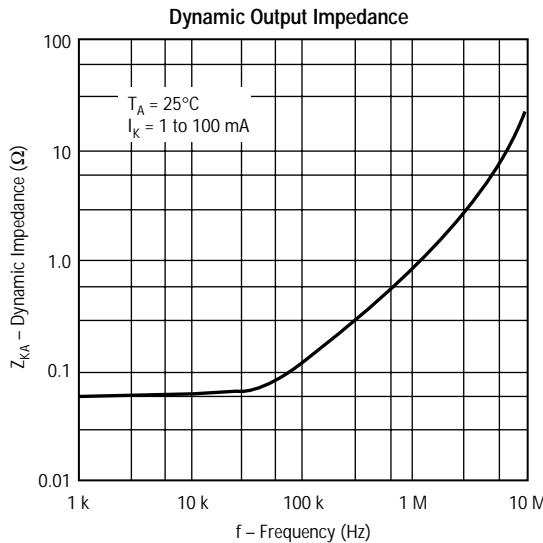


Figure 10

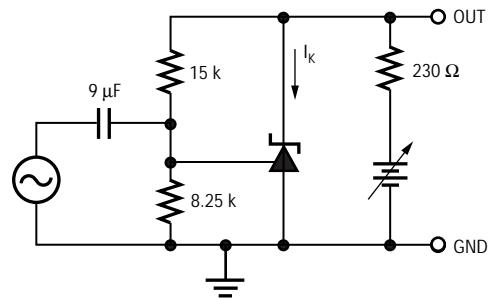
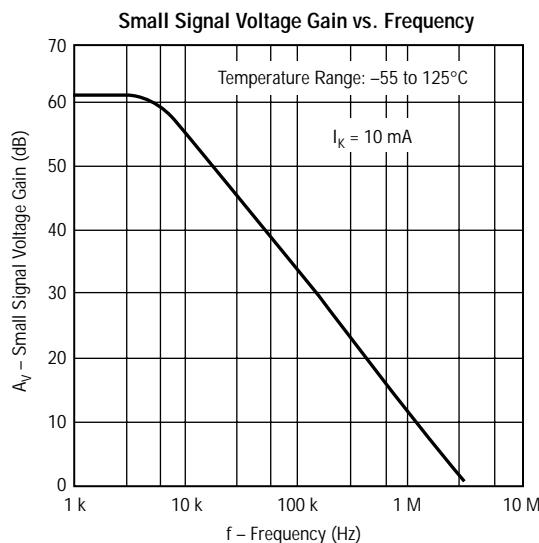


Figure 11

## Typical Performance Curves

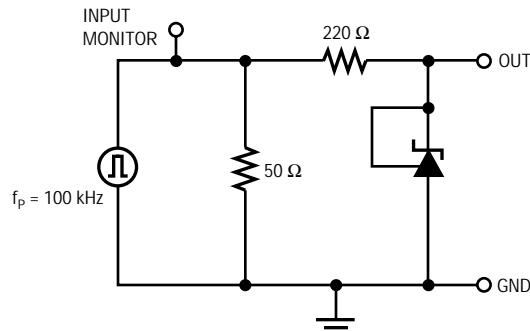
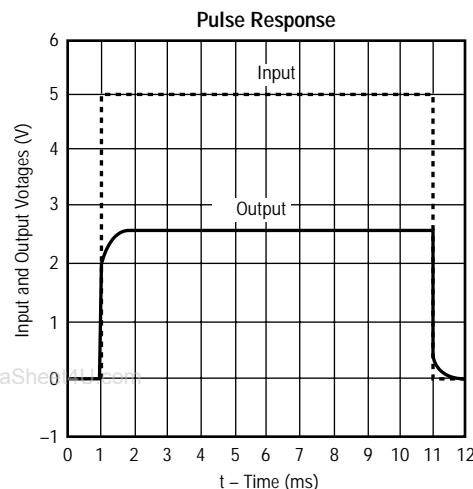


Figure 12

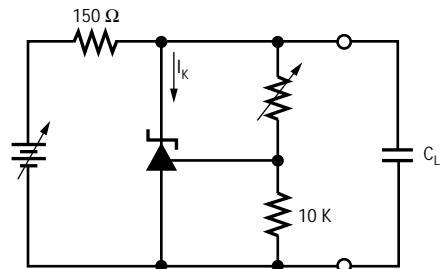
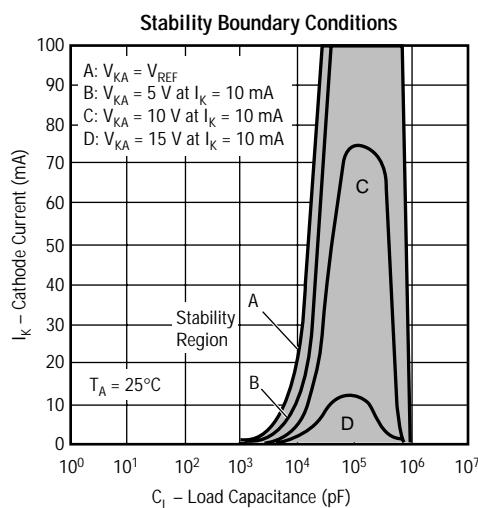


Figure 13